

## **Complementary MOSFET Half-Bridge (N- and P-Channel)**

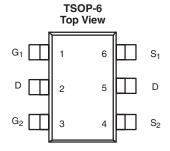
PRODUCT SUMMARY				
	V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	
N-Channel	20	0.300 at V <sub>GS</sub> = 4.5 V	1.4	
		0.410 at V <sub>GS</sub> = 3.0 V	1.2	
P-Channel	- 20	0.640 at V <sub>GS</sub> = - 4.5 V	- 0.96	
		0.980 at V <sub>GS</sub> = - 3.0 V	- 0.78	

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>a</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

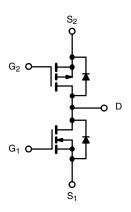






Ordering Information: Si3850ADV-T1-E3 (Lead (Pb)-free)

Si3850ADV-T1-GE3 (Lead (Pb)-free and Halogen-free)



<b>ABSOLUTE MAXIMUM RATINGS</b>	<b>S</b> T <sub>A</sub> = 25 °C, unle	ss otherwise	noted		
Parameter		Symbol	N-Channel	P-Channel	Uni
Drain-Source Voltage		$V_{DS}$	20 - 20		V
Gate-Source Voltage		V <sub>GS</sub>	±		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I_	1.4	- 0.96	
	T <sub>A</sub> = 70 °C	I <sub>D</sub>	1.1	- 0.77	
Pulsed Drain Current		I <sub>DM</sub>	3.5	- 2.0	7 ^
Continuous Source Current (Diode Conduction) <sup>a</sup>		I <sub>S</sub>	0.9	- 0.9	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.08		w
(Surface Mounted on FR4 Board)	T <sub>A</sub> = 70 °C	' D	0.7	70	vv
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stq</sub>	- 55 t	°C	

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	N- or P-Channel	Unit		
Maximum Junction-to-Ambient (Surface Mounted on FR4 Board, ± ≤ 10 s)	R <sub>thJA</sub>	115	°C/W		

Note:

Maximum under Steady State condition is 150 °C/W.



		ss otherwise noted		N#:	T	Mari	1112
Parameter	Symbol	Test Conditions		Min.	Тур.	Max.	Unit
Static		V V 1 050 A			T		
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	N-Ch	0.6		1.5	V
		$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	P-Ch	- 0.6		- 1.5	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$				± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	N-Ch			1	- μΑ
		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$	P-Ch			- 1	
		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$	N-Ch			10	
		$V_{DS}$ = - 20 V, $V_{GS}$ = 0 V, $T_{J}$ = 70 °C	P-Ch			- 10	
On-State Drain Current <sup>b</sup>	I- c	$V_{DS} = 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	N-Ch	3.0			А
	I <sub>D(on)</sub>	$V_{DS} = -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	P-Ch	- 1.5			
Drain-Source On-State Resistance <sup>b</sup>		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 0.5 A	N-Ch		0.240	0.300	Ω
	B	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 0.5 A	P-Ch		0.510	0.640	
	R <sub>DS(on)</sub>	$V_{GS} = 3.0 \text{ V}, I_D = 0.5 \text{ A}$	N-Ch		0.325	0.410	
		V <sub>GS</sub> = - 3.0 V, I <sub>D</sub> = - 0.5 A	P-Ch		0.780	0.980	
	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 A	N-Ch		1.8		S
Forward Transconductance <sup>b</sup>		V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 1 A	P-Ch		1.1		
h	V <sub>SD</sub>	I <sub>S</sub> = 0.9 A, V <sub>GS</sub> = 0 V	N-Ch		0.87	1.2	V
Diode Forward Voltage <sup>b</sup>		I <sub>S</sub> = - 0.8 A, V <sub>GS</sub> = 0 V	P-Ch		- 1.0	- 1.3	
Dynamic <sup>b</sup>	•				I.		
Total Cata Chausa			N-Ch		0.95	1.4	
Total Gate Charge	$Q_g$	N-Channel	P-Ch		1.10	1.7	
Gate-Source Charge	Q.	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1 \text{ A}$	N-Ch		0.22		nC
date-oddice onlarge	$Q_{gs}$	P-Channel	P-Ch		0.28		nC
Gate-Drain Charge	$Q_{gd}$	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1 \text{ A}$	N-Ch		0.24		
	gu		P-Ch		0.26		
Gate Resistance	$R_{g}$		N-Ch		3.5	5.3	Ω
	9		P-Ch		10.5	16	
Turn-On Delay Time	t <sub>d(on)</sub>	N-Channel	N-Ch P-Ch		8	14	_
		$V_{DD} = 10 \text{ V}, R_L = 10 \Omega$ $I_D \approx 0.9 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	N-Ch		13 16	20 25	
Rise Time	t <sub>r</sub>		P-Ch		34	50	
			N-Ch		20	30	
Turn-Off Delay Time	t <sub>d(off)</sub>	P-Channel	P-Ch		18	30	ns
	<del> </del>	$V_{DD} = -10 \text{ V}, R_L = 10 \Omega$ $I_D \cong -0.9 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	N-Ch		9	15	
Fall Time	t <sub>f</sub>	D = 0.075, GEN = 7.0 4, rig = 132	P-Ch		18	30	
	t <sub>rr</sub>	I <sub>F</sub> = 0.9 A, dI/dt = 100 A/μs	N-Ch		20	30	
Body Diode Reverse Recovery Tme		I <sub>F</sub> = - 0.9 A, dl/dt = 100 A/μs	P-Ch		25	40	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 0.9 A, dI/dt = 100 A/μs	N-Ch		9	15	nC
		I <sub>F</sub> = - 0.9 A, dl/dt = 100 A/μs	P-Ch		9	15	

#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Guaranteed by design, not subject to production testing.

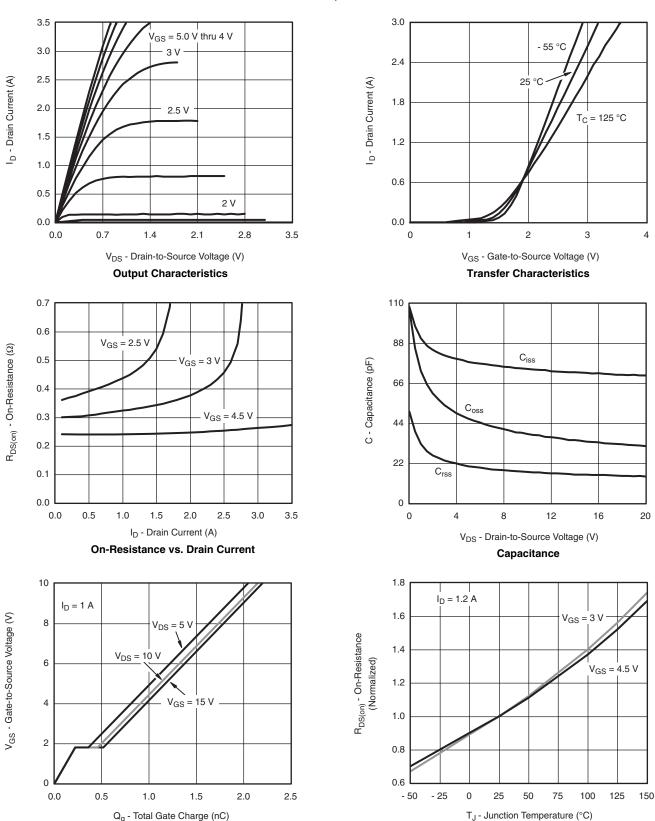
b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.







#### N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

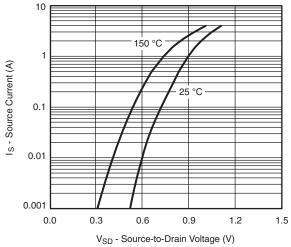


**Gate Charge** 

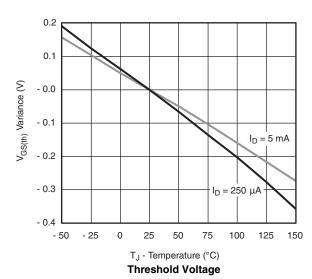
On-Resistance vs. Junction Temperature

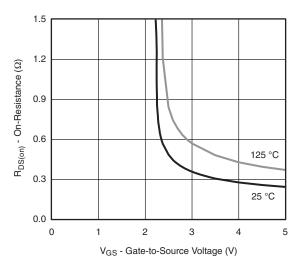
# VISHAY

## N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

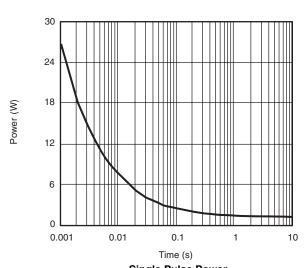


#### Source-Drain Diode Forward Voltage

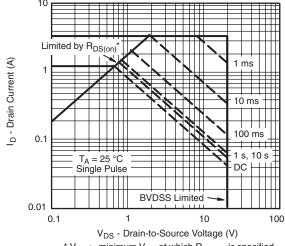




On-Resistance vs. Gate-to-Source Voltage



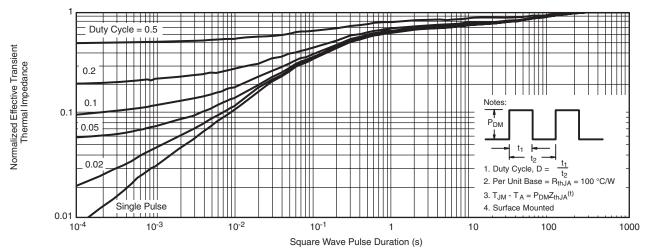
Single Pulse Power



 $^{\star}$  V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

**Safe Operating Area** 

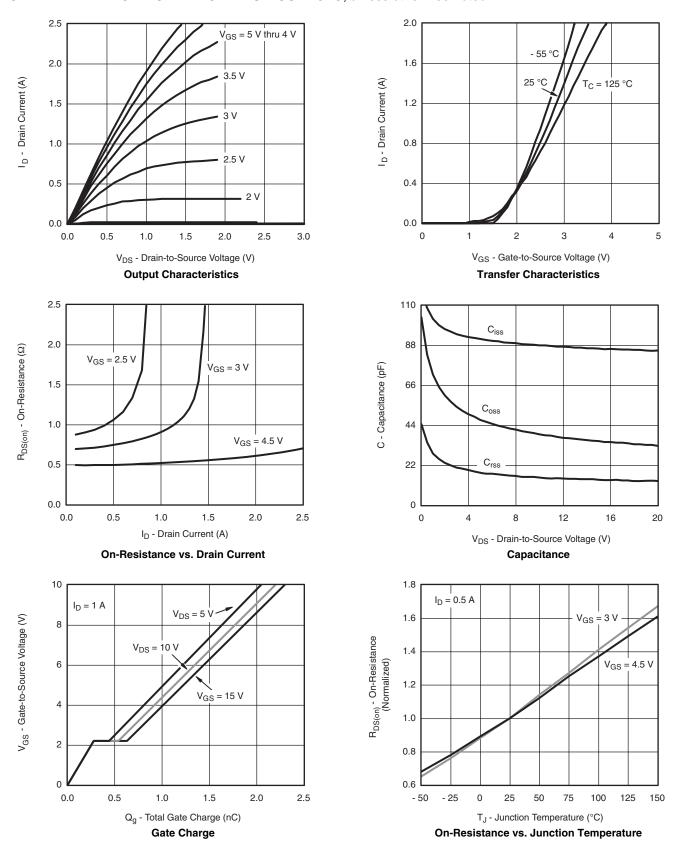
### N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

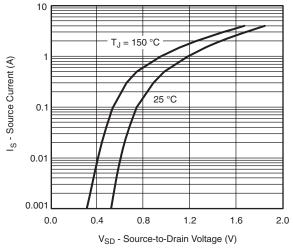
# VISHAY

## P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

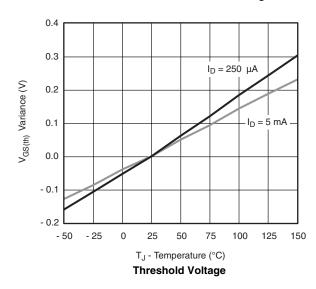




#### P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

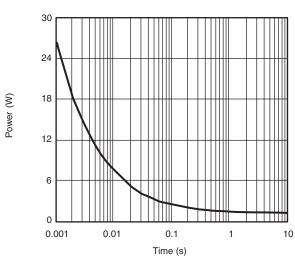


#### Source-Drain Diode Forward Voltage

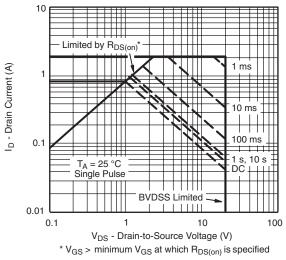


3.0 (C) 2.4 O 1.2 O 1.2 O 0 0 1 2 3 4 5 V<sub>GS</sub> - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

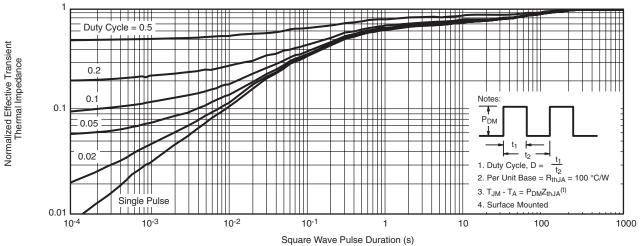


Single Pulse Power vs. Junction-to-Ambient





#### P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg273789">www.vishay.com/ppg273789</a>.



## **Legal Disclaimer Notice**

Vishay

### **Disclaimer**

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.